

**Search Notes**

Application/Control No.

10/757,610

Examiner

Phu Vu

Applicant(s)/Patent under  
Reexamination

NOGUCHI ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	155-156	4/18/2005	P.V.
349	134, 136	4/18/2005	P.V.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR